

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

IKEDA, HIROYUKI

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
257	59, 64	3/6/2005	TT
257	66, 70	3/6/2005	TT
257	72, 75	3/6/2005	TT
257	365, 366	3/6/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR